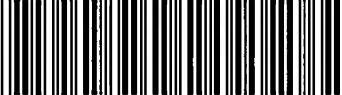
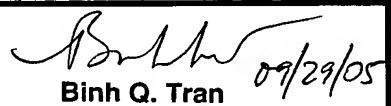


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/700,223	VAN NIEUWSTADT ET AL.
	Examiner	Art Unit
	BINH Q. TRAN	3748

ORIGINAL			CROSS REFERENCE(S)					
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
60	286	60	274	297	303			
INTERNATIONAL CLASSIFICATION								
F	O	I	N	3	00			
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				/				
				/				
				/				
(Assistant Examiner) (Date)			 Binh Q. Tran Patent Examiner Technology Center 3700 (Primary Examiner) (Date)			Total Claims Allowed: 7		
(Legal Instruments Examiner) (Date)						O.G. Print Claim(s) 6	O.G. Print Fig. 2	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1	1		31		61		151
2	2		32		62		152
3	3		33		63		153
4	4		34		64		154
5	5		35		65		155
8			36		66		156
7			37		67		157
8			38		68		158
6	9		39		69		159
7	10		40		70		160
11			41		71		161
12			42		72		162
13			43		73		163
14			44		74		164
15			45		75		165
16			46		76		166
17			47		77		167
18			48		78		168
19			49		79		169
20			50		80		170
21			51		81		171
22			52		82		172
23			53		83		173
24			54		84		174
25			55		85		175
26			56		86		176
27			57		87		177
28			58		88		178
29			59		89		179
30			60		90		180
					120		210